

EMI TEST REPORT

Test Report No. 16317384H

Customer	DENSO CORPORATION
Description of EUT	LiDsEYE
Model Number of EUT	DN-ILR-001
FCC ID	HYQDNILR001
Test Regulation	FCC Part 15 Subpart B, Class B
Test Result	Complied
Issue Date	May 25, 2026
Remarks	-

Representative test engineerHiroki Numata
Engineer**Approved by**Shinichi Miyazono
Leader

CERTIFICATE 5107.02

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- ☒ There is no testing item of "Non-accreditation".

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- If the latest version is a revision, it replaces the previous version. See the table below for revisions and versions.

REVISION HISTORY

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	16317384H	May 25, 2026	-

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	Hori.	Horizontal
AAN	Asymmetric Artificial Network	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	I/O	Input/Output
AE	Auxiliary equipment	IEC	International Electrotechnical Commission
AM	Amplitude Modulation	IEEE	Institute of Electrical and Electronics Engineers
AMN	Artificial Mains Network	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISN	Impedance Stabilization Network
AP	Access Point	ISO	International Organization for Standardization
ASK	Amplitude Shift Keying	JAB	Japan Accreditation Board
Atten., ATT	Attenuator	LAN	Local Area Network
AV	Average	LCL	Longitudinal Conversion Loss
BPSK	Binary Phase-Shift Keying	LIMS	Laboratory Information Management System
BR	Bluetooth Basic Rate	LISN	Line Impedance Stabilization Network
BT	Bluetooth	MRA	Mutual Recognition Arrangement
BT LE	Bluetooth Low Energy	N/A	Not Applicable
BW	BandWidth	NIST	National Institute of Standards and Technology
C.F	Correction Factor	NS	No signal detect.
Cal Int	Calibration Interval	NSA	Normalized Site Attenuation
CAV	CISPR AV	OBW	Occupied BandWidth
CCK	Complementary Code Keying	OFDM	Orthogonal Frequency Division Multiplexing
CDN	Coupling Decoupling Network	PER	Packet Error Rate
Ch., CH	Channel	PK	Peak
CISPR	Comite International Special des Perturbations Radioelectriques	P _{LT}	long-term flicker severity
Corr.	Correction	POHC(A)	Partial Odd Harmonic Current
CPE	Customer premise equipment	Pol., Pola.	Polarization
CW	Continuous Wave	PR-ASK	Phase Reversal ASK
DBPSK	Differential BPSK	P _{ST}	short-term flicker severity
DC	Direct Current	QAM	Quadrature Amplitude Modulation
DET	Detector	QP	Quasi-Peak
D-factor, D.fac.	Distance factor	QPSK	Quadrature Phase Shift Keying
Dmax	maximum absolute voltage change during an observation period	r.m.s., RMS	Root Mean Square
DQPSK	Differential QPSK	RBW	Resolution BandWidth
DSSS	Direct Sequence Spread Spectrum	RE	Radio Equipment
DUT	Device Under Test	REV	Reverse
EDR	Enhanced Data Rate	RF	Radio Frequency
e.i.r.p., EIRP	Equivalent Isotropically Radiated Power	RFID	Radio Frequency Identifier
EM clamp	Electromagnetic clamp	RNSS	Radio Navigation Satellite Service
EMC	ElectroMagnetic Compatibility	RSS	Radio Standards Specifications
EMI	ElectroMagnetic Interference	Rx	Receiving
EMS	ElectroMagnetic Susceptibility	S.fac.	Site factor
EN	European Norm	SINAD	Ratio of (Signal + Noise + Distortion) to (Noise + Distortion)
e.r.p., ERP	Effective Radiated Power	S/N	Signal to Noise ratio
ETSI	European Telecommunications Standards Institute	SA, S/A	Spectrum Analyzer
EU	European Union	SABS	South African Bureau of Standards
EUT	Equipment Under Test	SANS	South African National Standards
Fac.	Factor	SG	Signal Generator
FCC	Federal Communications Commission	SVSWR	Site-Voltage Standing Wave Ratio
FHSS	Frequency Hopping Spread Spectrum	THC(A)	Total Harmonic Current
FM	Frequency Modulation	THD(%)	Total Harmonic Distortion
Freq.	Frequency	TR, T/R	Test Receiver
FSK	Frequency Shift Keying	Tx	Transmitting
Fund	Fundamental	UFA	Uniform field area
FWD	Forward	VBW	Video BandWidth
GFSK	Gaussian Frequency-Shift Keying	Vert.	Vertical
GNSS	Global Navigation Satellite System	WLAN	Wireless LAN
GPS	Global Positioning System	xDSL	Generic term for all types of DSL technology (DSL: Digital Subscriber Line)

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SECTION 1: Customer information

Company Name	DENSO CORPORATION
Address	1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number	+81-50-1802-1063
Contact Person	Shinji Kashiwada

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Description	LiDsEYE
Model Number	DN-ILR-001
Serial Number	Refer to SECTION 4.2
Condition	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	November 20, 2025
Test Date	November 25, 2025

2.2 Product Description

General Specification

Rating	DC 9.0 V to 32 V
Clock frequency (ies) in the system	1488 MHz (Max.)

SECTION 3: Test Summary

3.1 Test Specification

Test Specification	FCC Part 15 Subpart B The latest version on the first day of the testing period
Title	FCC 47CFR Part15 Radio Frequency Device Subpart B Unintentional Radiators

3.2 Reference Standards

ANSI/USEMCSC C63.2-2023
ANSI C63.4-2014+C63.4a-2017
ANSI C63.5-2017
ANSI C63.25.1-2018

3.3 Summary of Test Results

Item	Limits	Result	Remarks
Conducted emission	FCC: Part 15 Subpart B 15.107(a) ISED: RSS-Gen 7.2	Complied	-
Radiated emission	FCC: Part 15 Subpart B 15.109(a) ISED: RSS-Gen 7.3	Complied	-
* Note: UL Japan, Inc.'s EMI Work Procedure: Work Instructions-ULID-003591.			

3.4 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.5 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Conducted emission

Item	Frequency range	Unit	Calculated Uncertainty (+/-)
AMN (LISN)	0.15 MHz to 30 MHz	dB	3.3

Radiated emission

Measurement distance	Frequency range		Unit	Calculated Uncertainty (+/-)
3 m	30 MHz to 200 MHz	Horizontal	dB	5.0
		Vertical	dB	5.0
	200 MHz to 1000 MHz	Horizontal	dB	5.2
		Vertical	dB	6.2
3 m	1 GHz to 6 GHz		dB	5.1
	6 GHz to 18 GHz		dB	5.4

3.6 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber (SAC1)	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber (SAC2)	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber (SAC3)	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room (PR3)	3 m
No.3 shielded room (SR3)	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber (SAC4)	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room (PR4)	3 m
No.4 shielded room (SR4)	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber (SAC5)	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room (MR5)	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room (SR6)	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room (MR6)	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room (SR7)	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room (MR8)	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room (MR9)	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room (SR10)	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room (MR11)	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room (MR12)	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0 m for No.1, No.2, No.3, No.4, and No.5 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.7 Test data, Test instruments, and Test set up

Refer to APPENDIX.

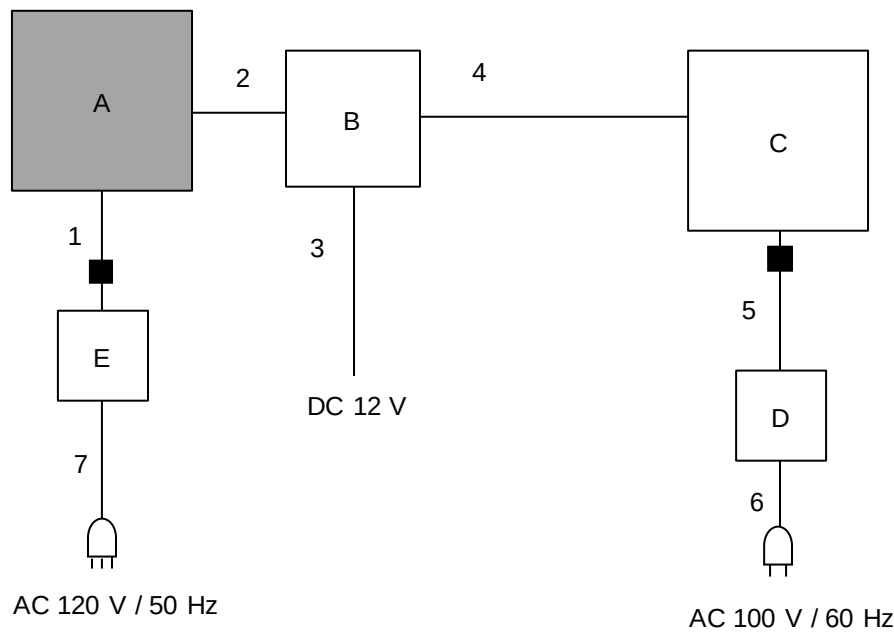
SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	1. Normal Operating
Software(s)	LiDsView Version: 4.1.1

4.2 Configuration and peripherals

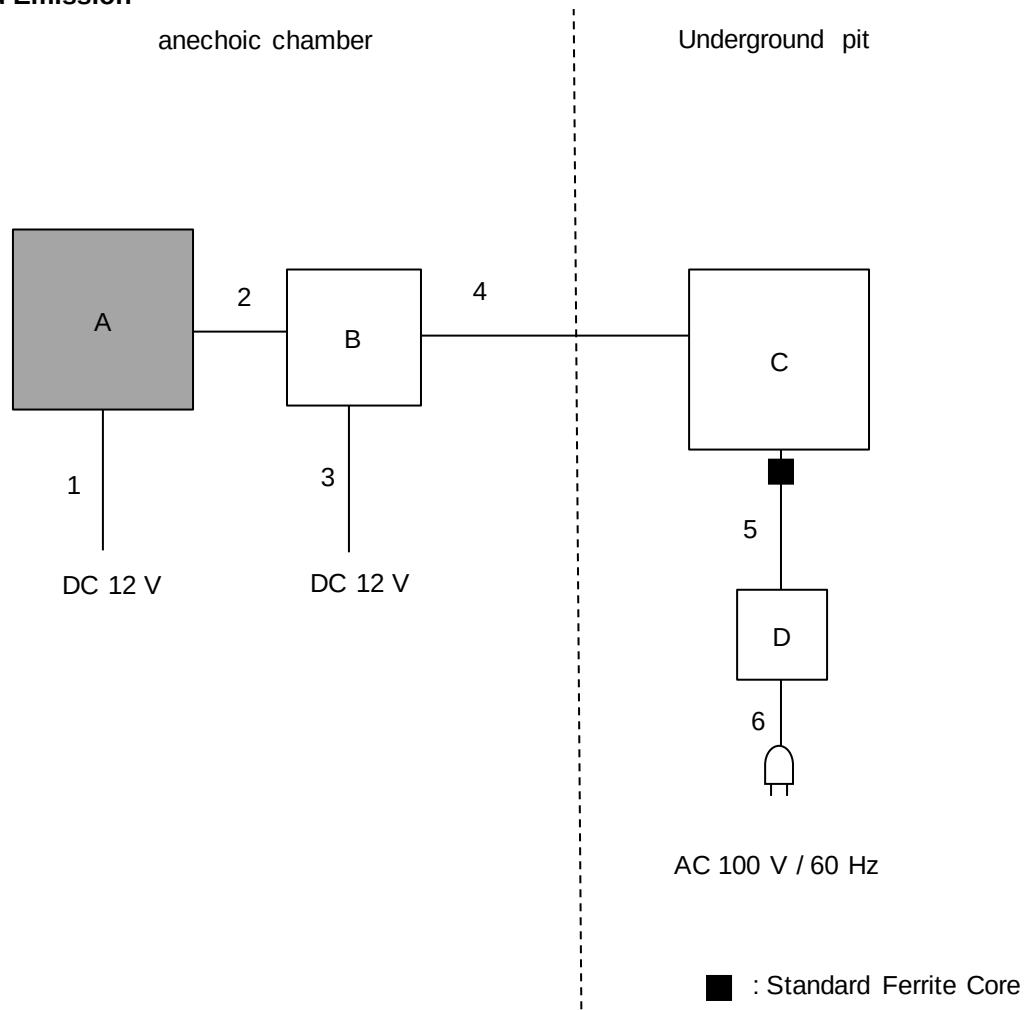
Conducted Emission



■ : Standard Ferrite Core

* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.
* As a result of comparing AC 120 V and AC 240 V at pre-check, conducted emission test was performed with AC 120 V of the worst voltage as representative.

Radiated Emission



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.
* As a result of comparing DC 12 V and DC 24 V at pre-check, radiated emission test was performed with DC 12 V of the worst voltage as representative.

Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	LiDsEYE	DN-ILR-001	0000005	DENSO CORPORATION	EUT
B	Media converter	RAD-MOON2	RN2656	Intrepid	-
C	Laptop PC	CF-SV7RDAVS	9IKSC48031	Panasonic	-
D	AC Adapter	CF-AA62J2C	64L2CM11118923195A	Panasonic	-
E	AC Adapter	GST120A12	SC289T8530	MEAN WELL	*1)

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.3	Unshielded	Unshielded	-
2	Automotive Ethernet Cable	2.0	Shielded	Shielded	-
3	DC Cable	1.2	Unshielded	Unshielded	-
4	LAN Cable	5.0	Shielded	Shielded	-
5	DC Cable	1.0	Unshielded	Unshielded	-
6	AC Cable	0.8	Unshielded	Unshielded	-
7	AC Cable	1.0	Unshielded	Unshielded	*1)

*1) Used for Conducted Emission test

SECTION 5: Conducted Emission

5.1 Operating environment

Date	Test site	Temperature	Humidity	Engineer	Mode
See data	See data	See data	See data	See data	See data

5.2 Test configuration

EUT was placed on the platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of the platform was located 40 cm to the vertical conducting plane. The rear of EUT and its peripherals was aligned and flushed with rear of the platform. All other surfaces of the platform were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from the LISN/AMN and excess AC cable was bundled in center. I/O cables that were connected to the other peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN/AMN to the input power source. All unused 50 ohm connectors of the LISN/AMN were resistivity terminated in 50 ohm when not connected to the measuring equipment.

Photographs of the set up are shown in APPENDIX.

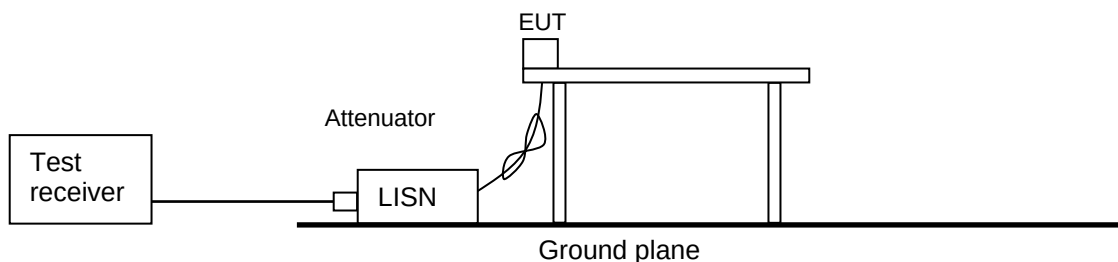
Frequency range : 0.15 MHz to 30 MHz
EUT position : Table top
EUT operation mode : See Clause 4.1

5.3 Test procedure

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT within a semi anechoic chamber. The EUT was connected to a Line Impedance Stabilization Network (LISN)/ Artificial Mains network (AMN). An overview sweep with peak detection has been performed. The measurements have been performed with a quasi-peak detector and if required, with an average detector. The conducted emission measurements were made with the following detector function of the test receiver.

Detector Type : QP and CAV
IF Bandwidth : 9 kHz

Figure 1: Test Setup



5.4 Test result

Summary of the test results: Pass

The test result is rounded off, so some differences might be observed.

SECTION 6: Radiated Emission

6.1 Operating environment

Date	Test site	Temperature	Humidity	Engineer	Mode
See data	See data	See data	See data	See data	See data

6.2 Test configuration

EUT was placed on the platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The EUT was set on the edge of the platform.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

Photographs of the set up are shown in APPENDIX.

6.3 Test conditions

Frequency range	:	30 MHz to 200 MHz (Biconical antenna) 200 MHz to 1000 MHz (Logperiodic antenna) 1000 MHz to 8000 MHz (Horn antenna)
Test distance	:	See Figure 2
EUT position	:	Table top
EUT operation mode	:	See Clause 4.1

6.4 Test procedure

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

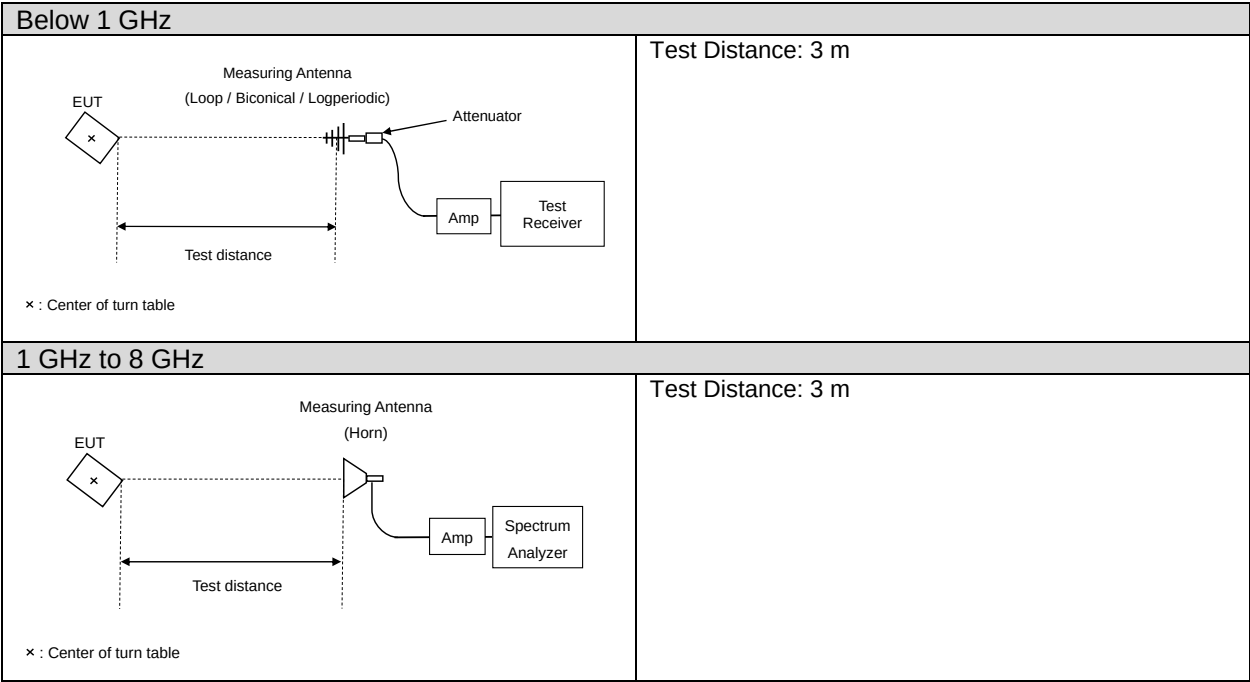
The radiated emission measurements were made with the following detector function of the Test Receiver and the Spectrum Analyzer.

Test antenna was aimed at the emission source for receiving the maximum signal and always kept. (Above 1 GHz)

Frequency	Below 1 GHz	Above 1 GHz
Instrument used	Test Receiver	Spectrum Analyzer
IF Bandwidth	QP: BW 120 kHz	PK: RBW: 1 MHz / VBW: 3 MHz AV *1): RBW: 1 MHz / VBW: 10 Hz

*1) When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Figure 2: Test Setup



The test was made on EUT at the normal use position.

6.5 Test result

Summary of the test results: Pass

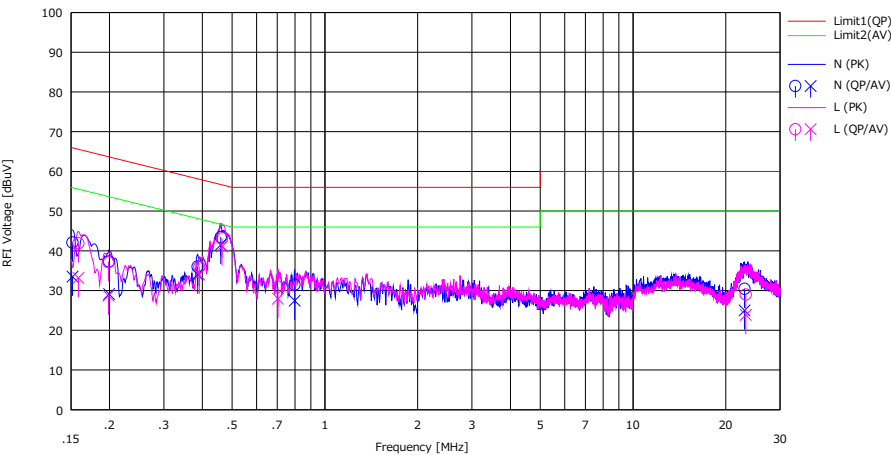
Test results are rounded off and limit are rounded down, so some differences might be observed.

APPENDIX 1: Test data

Conducted Emission

Mode	Mode 1			
Date	Test site	Temperature	Humidity	Engineer
November 25, 2025	SAC3	22 deg. C	44 % RH	Hiroki Numata

Limit : FCC_Part 15 Subpart B(15.107)_Class B / ICES-003 Issue 7 October 2020_Class B



No.	Freq. [MHz]	Reading		USN [dB]	LOSS [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]			<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.15170	28.90	20.30	0.05	13.15	42.10	33.50	65.91	55.91	23.81	22.41	N	
2	0.19930	24.10	15.90	0.05	13.16	37.31	29.11	63.64	53.64	26.33	24.53	N	
3	0.38630	22.80	20.80	0.05	13.18	36.03	34.03	58.14	48.14	22.11	14.11	N	
4	0.45940	30.20	28.30	0.05	13.19	43.44	41.54	56.70	46.70	13.26	5.16	N	
5	0.79770	18.20	14.20	0.06	13.21	31.47	27.47	56.00	46.00	24.53	18.53	N	
6	23.02000	16.00	10.60	0.51	13.92	30.43	25.03	60.00	50.00	29.57	24.97	N	
7	0.15850	28.70	20.00	0.04	13.15	41.89	33.19	65.54	55.54	23.65	22.35	L	
8	0.19850	23.90	15.50	0.04	13.16	37.10	28.70	63.67	53.67	26.57	24.97	L	
9	0.39140	22.70	20.80	0.04	13.18	35.92	34.02	58.03	48.03	22.11	14.01	L	
10	0.46370	29.90	27.90	0.04	13.19	43.13	41.13	56.63	46.63	13.50	5.50	L	
11	0.70420	17.70	14.70	0.04	13.21	30.95	27.95	56.00	46.00	25.05	18.05	L	
12	23.24000	14.50	9.40	0.56	13.92	28.98	23.88	60.00	50.00	31.02	26.12	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + LISN + LOSS (CABLE + ATT)
Except for the above table: adequate margin data below the limits.

Radiated Emission

Mode	Mode 1				
Date	Test site	Temperature	Humidity	Engineer	Measurement Range
November 25, 2025	SAC3	22 deg. C	44 % RH	Hiroki Numata	Below 1 GHz

Limit : FCC_Part 15 Subpart B(15.109)_Class B

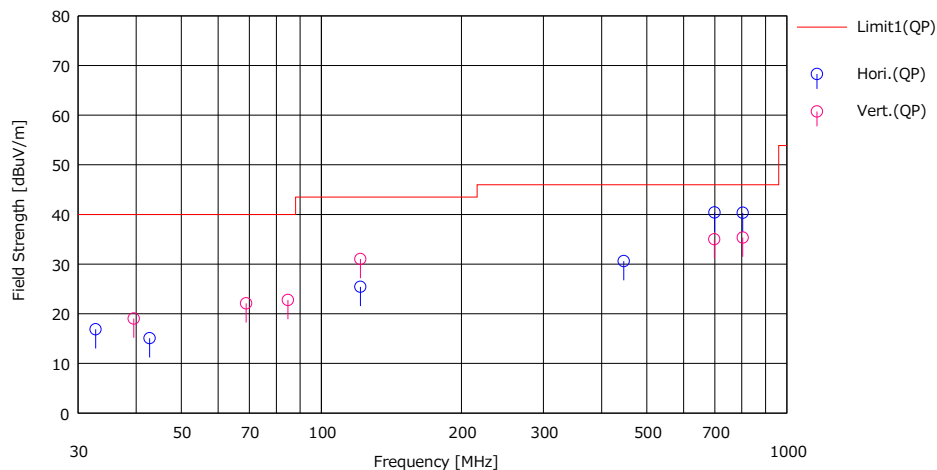


CHART: WITH FACTOR

ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN

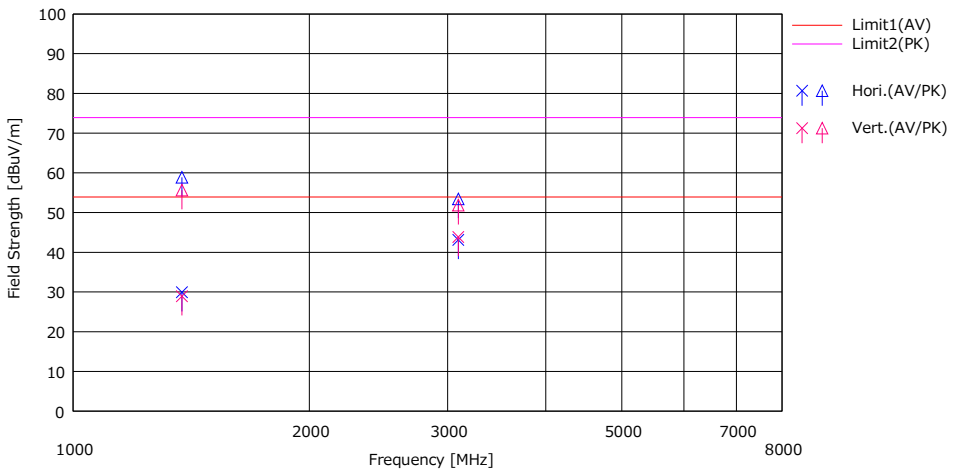
CALCULATION: RESULT = READING + ANT FACTOR + LOSS(CABLE + ATT) - GAIN(AMP)

Except for the above table: adequate margin data below the limits.

Radiated Emission

Mode	Mode 1				
Date	Test site	Temperature	Humidity	Engineer	Measurement Range
November 25, 2025	SAC3	22 deg. C	44 % RH	Hiroki Numata	1 GHz to 8 GHz

Limit : FCC_Part 15 Subpart B(15.109)_Class B



No.	Freq. [MHz]	Reading		Ant.Fac [dB/m]	Loss [dB]	Gain [dB]	Result		Limit		Margin		Pola [H/V]	Height [cm]	Angle [deg]	Ant. Type	Comment
		(AV) [dBuV]	(PK) [dBuV]				(AV) [dBuV/m]	(PK) [dBuV/m]	(AV) [dBuV/m]	(PK) [dBuV/m]	(AV) [dB]	(PK) [dB]					
1	1376.116	36.30	65.20	25.54	1.76	33.66	29.94	58.84	53.90	73.90	23.96	15.06	Hori.	100	16	H2.1	
2	3095.986	43.40	53.70	28.72	2.73	31.71	43.14	53.44	53.90	73.90	10.76	20.46	Hori.	100	357	H2.1	
3	1376.116	35.30	62.00	25.54	1.76	33.66	28.94	55.64	53.90	73.90	24.96	18.26	Vert.	100	339	H2.1	
4	3095.986	44.10	52.10	28.72	2.73	31.71	43.84	51.84	53.90	73.90	10.06	22.06	Vert.	100	10	H2.1	

CHART: WITH FACTOR
ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN
CALCULATION: RESULT = READING + ANT FACTOR + LOSS(CABLE) - GAIN(AMP)
Except for the above table: adequate margin data below the limits.

APPENDIX 2: Test instruments

Test equipment

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
CE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	07/09/2025	24
CE	244709	Thermo-Hygrometer	HIOKI E. E. CORPORATION	LR5001	231202103	01/19/2025	12
CE	141532	DIGITAL HiTESTER	HIOKI E. E. CORPORATION	3805	051201197	01/16/2025	12
CE	142183	Measure	KOMELON	KMC-36	-	10/20/2025	12
CE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
CE	141357	LISN(AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-729	07/07/2025	12
CE	141537	LISN(AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-731	07/04/2025	12
CE	141248	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	12/03/2024	12
CE	141358	LISN(AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-730	07/03/2025	12
CE	141216	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM14/sucoform141-PE/421-010/RFM-E321(SW)	-/00640	07/04/2025	12
CE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	06/30/2025	12
CE	141933	Terminator	TME	CT-01BP	-	12/23/2024	12
CE	141934	Terminator	TME	CT-01BP	-	04/04/2025	12
RE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	07/09/2025	24
RE	244709	Thermo-Hygrometer	HIOKI E. E. CORPORATION	LR5001	231202103	01/19/2025	12
RE	141532	DIGITAL HiTESTER	HIOKI E. E. CORPORATION	3805	051201197	01/16/2025	12
RE	142183	Measure	KOMELON	KMC-36	-	10/20/2025	12
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	142013	AC3_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/14/2025	24
RE	142314	Attenuator	Pasternack Enterprises	PE7390-6	D/C 1504	06/24/2025	12
RE	141424	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103+BBA9106	1915	10/21/2025	12
RE	141323	Coaxial cable	UL-ISE	-	-	09/08/2025	12
RE	141266	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-191	08/14/2025	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/14/2025	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	06/30/2025	12
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9120D	557	05/20/2025	12
RE	141580	MicroWave System Amplifier	Keysight Technologies Inc	83017A	MY39500779	03/24/2025	12
RE	263275	Microwave Cable	Junkosha	MWX221-05000DMSDMS+MWX221-01000DMSDMS	2505S043+2503S145	05/20/2025	12
RE	141901	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY48250080	02/04/2025	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

CE: Conducted emission

RE: Radiated emission